

IGBT

TRENCHSTOP™ IGBT4 High Speed Chip IGC18T120T8Q

**Data Sheet** 

Industrial Power Control



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## TRENCHSTOP<sup>™</sup> IGBT4 High Speed Chip

#### Features:

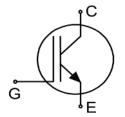
- 1200V trench & field stop technology
- Low switching losses
- Positive temperature coefficient
- Easy paralleling

#### Recommended for:

• Discrete components

#### **Applications:**

- High frequency drives
- Uninterruptible power supplies
- Welding
- Solar inverters



Chip Type	V <sub>CE</sub>	<i>I</i> <sub>Cn</sub> <sup>1</sup>	Die Size	Package
IGC18T120T8Q	1200V	15A	4.16mm x 4.34mm	Sawn on foil

### **Mechanical Parameters**

Die size		4.16 x 4.34		
Emitter pad size		See chip drawing		
Gate pad size		1.185 x 0.702	mm <sup>2</sup>	
Area total		18.05		
Thickness		115	μm	
Wafer size		200	mm	
Maximum possible ch	ips per wafer	1510		
Passivation frontside		Photoimide		
Pad metal 3200nm AlSiCu				
Backside metal		Ni Ag – system  To achieve a reliable solder connection it is strongly recommended not to consume the Ni layer completely during production process		
Die bond		Electrically conductive epoxy glue and soft sol	der	
Wire bond		AI, ≤500μm		
Reject ink dot size		Ø 0.65mm; max. 1.2mm		
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, temperature 17°C – 25°C		
(<6 months)	for open MBB bags	Acc. IEC 62258-3; Section 9.4 Storage Environ	ment.	

 $<sup>^{1}</sup>$  Nominal collector current at  $T_{\text{C}}$ =100°C for chip packaged in TO packages, see application example cited on page 5.

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### **Maximum Ratings**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>vj</sub> =25°C	V <sub>CE</sub>	1200	V
DC collector current, limited by $T_{\rm vj\;max}^{\;\;2}$	I <sub>C</sub>	-	Α
Pulsed collector current, $t_p$ limited by $T_{vj \max}$ 3	I <sub>C,puls</sub>	45	Α
Gate-emitter voltage	$V_{GE}$	±20	V
Virtual junction operating temperature	$T_{vj}$	-40 +175	°C
Short circuit data $^{3/4}$ $V_{GE}$ =15V, $V_{CC}$ =800V, $T_{vj}$ =150°C	t <sub>sc</sub>	10	μs

### Static Characteristics (tested on wafer), T<sub>vi</sub>=25°C

Parameter	Symbol Conditions		Value			Unit
Farameter			min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{\text{GE}}$ =0V, $I_{\text{C}}$ =0.5mA	1200	-	-	
Collector-emitter saturation voltage	$V_{\sf CEsat}$	$V_{\rm GE} = 15 \text{V}, I_{\rm C} = 15 \text{A}$	1.78	2.05	2.42	V
Gate-emitter threshold voltage	$V_{GE(th)}$	$I_{\rm C}$ =0.5mA, $V_{\rm GE}$ = $V_{\rm CE}$	5.3	5.8	6.3	
Zero gate voltage collector current	I <sub>CES</sub>	$V_{\text{CE}} = 1200 \text{V}, \ V_{\text{GE}} = 0 \text{V}$	-	-	2	μΑ
Gate-emitter leakage current	I <sub>GES</sub>	$V_{CE} = 0V, V_{GE} = 20V$	1	ı	120	nA
Integrated gate resistor	r <sub>G</sub>			none		Ω

### **Electrical Characteristics** <sup>3</sup>

Parameter	Symbol Conditions		Value			Unit
raiametei			min.	typ.	max.	Ollit
Collector-emitter saturation voltage	$V_{CEsat}$	$V_{\text{GE}}$ =15V, $I_{\text{C}}$ =15A, $T_{\text{vj}}$ =175°C	-	2.70	-	V
Input capacitance	C <sub>ies</sub>	V <sub>CE</sub> =25V,	-	875	1	nE
Reverse transfer capacitance	$C_{res}$	$V_{\text{GE}}$ =0V, $f$ =1MHz $T_{\text{vj}}$ =25°C	-	45	1	pF

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 $<sup>^2</sup>$  Depending on thermal properties of assembly.  $^3$  Not subject to production test - verified by design/characterization.

<sup>&</sup>lt;sup>4</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.



### **Further Electrical Characteristics**

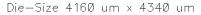
Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

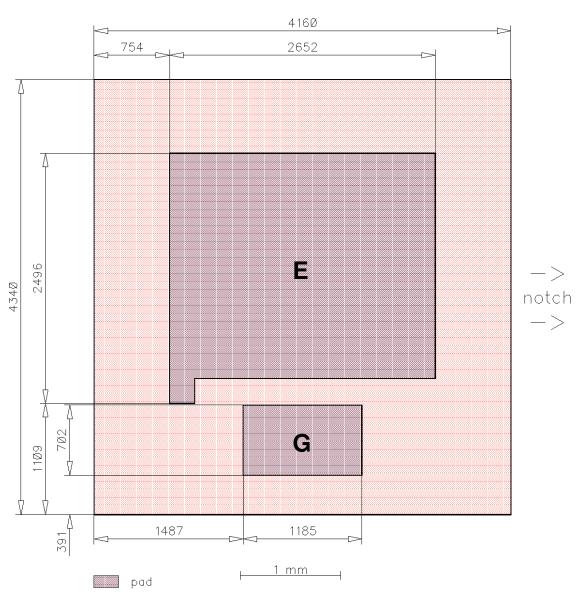
Application example	IKW15N120H3	Rev. 1.2
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### **Chip Drawing**





**E** = Emitter

**G** = Gate



Bare Die	Product	<b>Specifics</b>
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Test coverage at wafer level cannot cover all application conditions. Therefore it is recommended to test all characteristics which are relevant for the application at package level, including RBSOA and SCSOA.

Description		
	visual inspection according to failure catalogue	
Electrostatic [	Discharge Sensitive Device according to MIL-STD 883	
Revision His	tory	
Revision	Subjects (major changes since last revision)	Date
2.0	Final data sheet	13.10.2015
Rolovant Ani	olication Notes	

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